

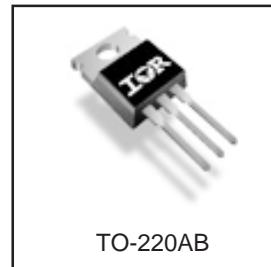
**Applications**

- High frequency DC-DC converters
- Motor Control
- Uninterruptible Power Supplies

|                        |                               |                      |
|------------------------|-------------------------------|----------------------|
| <b>V<sub>DSS</sub></b> | <b>R<sub>DS(on)</sub> max</b> | <b>I<sub>D</sub></b> |
| <b>200V</b>            | <b>0.055Ω</b>                 | <b>44A</b>           |

**Benefits**

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>OSS</sub> to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



**Absolute Maximum Ratings**

|   | <b>Parameter</b>                                | <b>Max.</b>            | <b>Units</b> |
|---|---|------------------------|--------------|
| I <sub>D</sub> @ T <sub>C</sub> = 25°C  | Continuous Drain Current, V <sub>GS</sub> @ 10V | 44                     | A            |
| I <sub>D</sub> @ T <sub>C</sub> = 100°C | Continuous Drain Current, V <sub>GS</sub> @ 10V | 31                     |              |
| I <sub>DM</sub>                         | Pulsed Drain Current ①                          | 180                    |              |
| P <sub>D</sub> @ T <sub>A</sub> = 25°C  | Power Dissipation                               | 2.4                    | W            |
| P <sub>D</sub> @ T <sub>C</sub> = 25°C  | Power Dissipation                               | 330                    |              |
|   | Linear Derating Factor                          | 2.2                    | W/°C         |
| V <sub>GS</sub>                         | Gate-to-Source Voltage                          | ± 30                   | V            |
| dv/dt                                   | Peak Diode Recovery dv/dt ③                     | 2.5                    | V/ns         |
| T <sub>J</sub>                          | Operating Junction and                          | -55 to + 175           | °C           |
| T <sub>STG</sub>                        | Storage Temperature Range                       |                        |              |
|   | Soldering Temperature, for 10 seconds           | 300 (1.6mm from case ) |              |
|   | Mounting torque, 6-32 or M3 screw               | 10 lbf•in (1.1N•m)     |              |

**Thermal Resistance**

|                  | <b>Parameter</b>                    | <b>Typ.</b> | <b>Max.</b> | <b>Units</b> |
|------------------|-------------------------------------|-------------|-------------|--------------|
| R <sub>θJC</sub> | Junction-to-Case                    | —           | 0.45        | °C/W         |
| R <sub>θCS</sub> | Case-to-Sink, Flat, Greased Surface | 0.50        | —           |              |
| R <sub>θJA</sub> | Junction-to-Ambient                 | —           | 62          |              |

Notes ① through ⑤ are on page 8

### Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max.  | Units    | Conditions  |
|---------------------------------|--------------------------------------|------|------|-------|----------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 200  | —    | —     | V        | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.26 | —     | V/°C     | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$     |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.055 | $\Omega$ | $V_{GS} = 10V, I_D = 26A$ ④                           |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 3.0  | —    | 5.5   | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25    | $\mu A$  | $V_{DS} = 200V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —    | 250   |          | $V_{DS} = 160V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100   | nA       | $V_{GS} = 30V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100  |          | $V_{GS} = -30V$                                       |

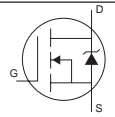
### Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                        | Parameter                       | Min. | Typ. | Max. | Units | Conditions                                      |
|------------------------|---------------------------------|------|------|------|-------|---|
| $g_{fs}$               | Forward Transconductance        | 21   | —    | —    | S     | $V_{DS} = 50V, I_D = 26A$                       |
| $Q_g$                  | Total Gate Charge               | —    | 91   | 140  | nC    | $I_D = 26A$                                     |
| $Q_{gs}$               | Gate-to-Source Charge           | —    | 24   | 36   |       | $V_{DS} = 160V$                                 |
| $Q_{gd}$               | Gate-to-Drain ("Miller") Charge | —    | 43   | 65   |       | $V_{GS} = 10V,$                                 |
| $t_{d(on)}$            | Turn-On Delay Time              | —    | 18   | —    |       | $V_{DD} = 100V$                                 |
| $t_r$                  | Rise Time                       | —    | 69   | —    | ns    | $I_D = 26A$                                     |
| $t_{d(off)}$           | Turn-Off Delay Time             | —    | 29   | —    |       | $R_G = 1.8\Omega$                               |
| $t_f$                  | Fall Time                       | —    | 32   | —    |       | $V_{GS} = 10V$ ④                                |
| $C_{iss}$              | Input Capacitance               | —    | 3430 | —    | pF    | $V_{GS} = 0V$                                   |
| $C_{oss}$              | Output Capacitance              | —    | 530  | —    |       | $V_{DS} = 25V$                                  |
| $C_{rss}$              | Reverse Transfer Capacitance    | —    | 100  | —    |       | $f = 1.0\text{MHz}$                             |
| $C_{oss}$              | Output Capacitance              | —    | 5310 | —    |       | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$ |
| $C_{oss}$              | Output Capacitance              | —    | 210  | —    |       | $V_{GS} = 0V, V_{DS} = 160V, f = 1.0\text{MHz}$ |
| $C_{oss \text{ eff.}}$ | Effective Output Capacitance    | —    | 400  | —    |       | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$ ⑤   |

### Avalanche Characteristics

|          | Parameter                      | Typ. | Max. | Units |
|----------|--------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy② | —    | 510  | mJ    |
| $I_{AR}$ | Avalanche Current①             | —    | 26   | A     |
| $E_{AR}$ | Repetitive Avalanche Energy①   | —    | 33   | mJ    |

### Diode Characteristics

|          | Parameter                              | Min.  | Typ. | Max. | Units | Conditions   |
|----------|--|---|------|------|-------|--|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 44   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —   | —    | 180  |       |  |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 26A, V_{GS} = 0V$ ④   |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 220  | 330  | ns    | $T_J = 25^\circ\text{C}, I_F = 26A$  |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 1860 | 2790 | nC    | $di/dt = 100A/\mu s$ ④   |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |  |

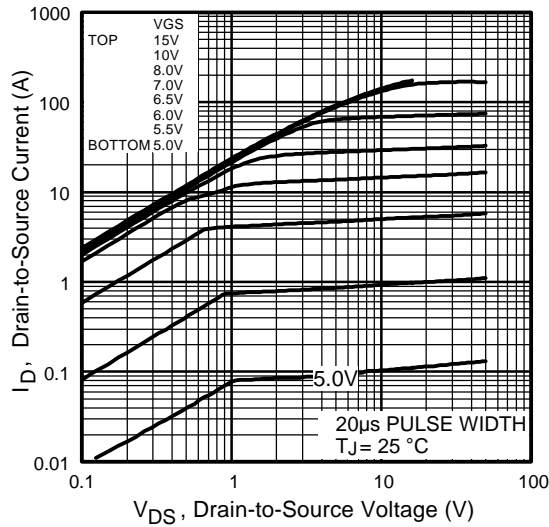


Fig 1. Typical Output Characteristics

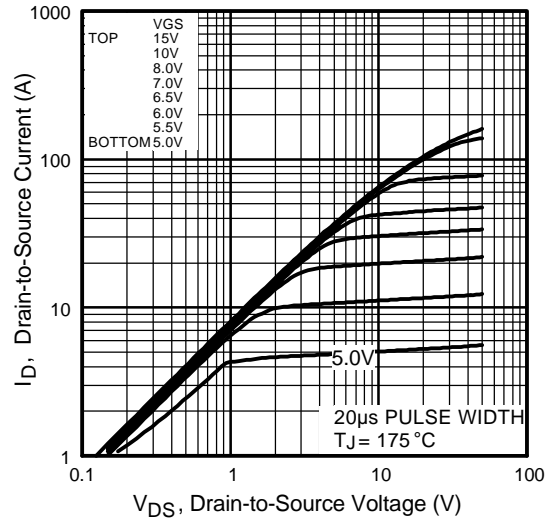


Fig 2. Typical Output Characteristics

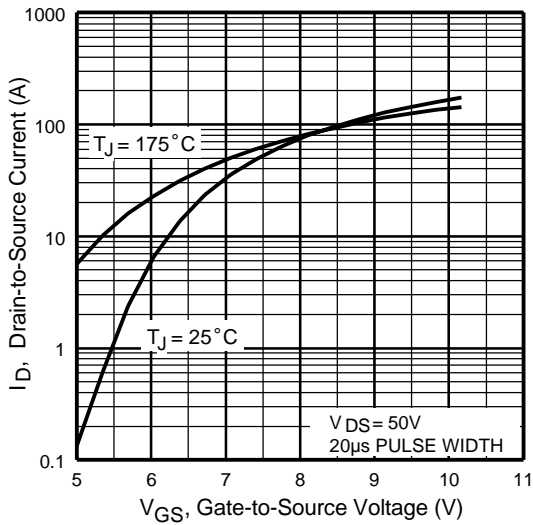


Fig 3. Typical Transfer Characteristics

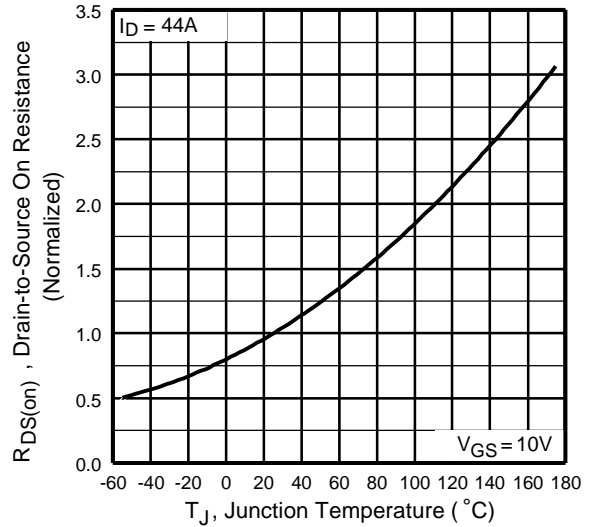
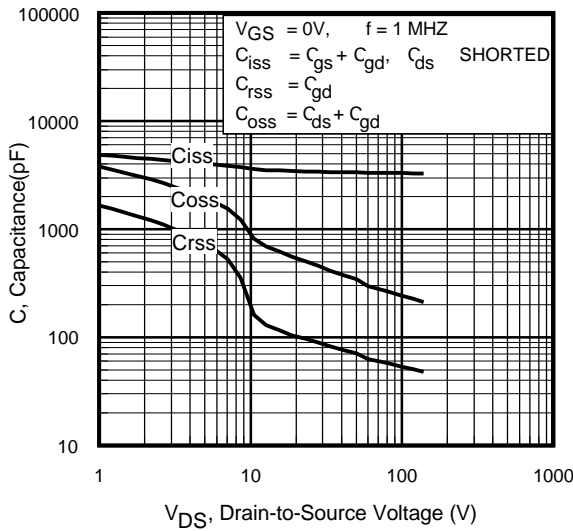
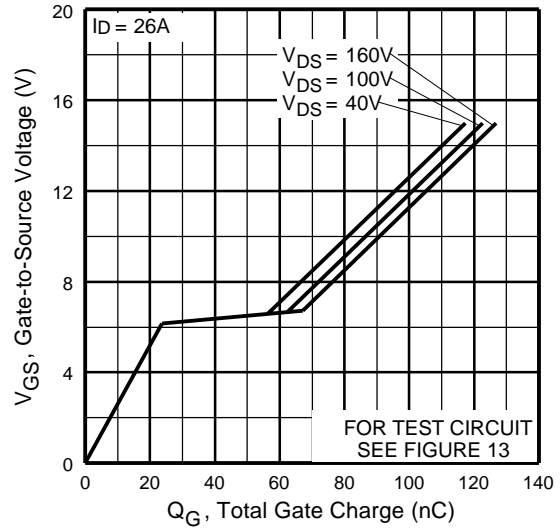


Fig 4. Normalized On-Resistance Vs. Temperature

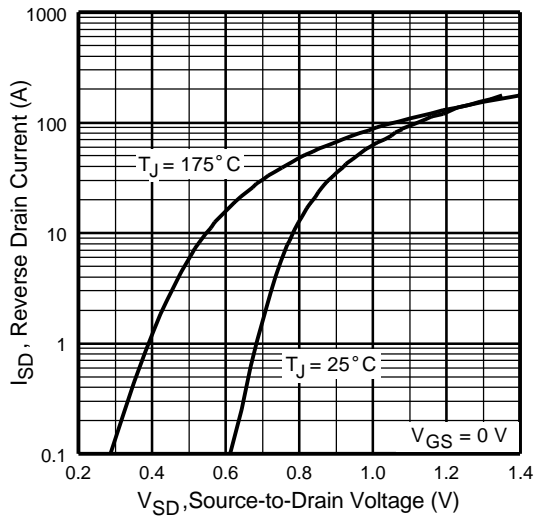
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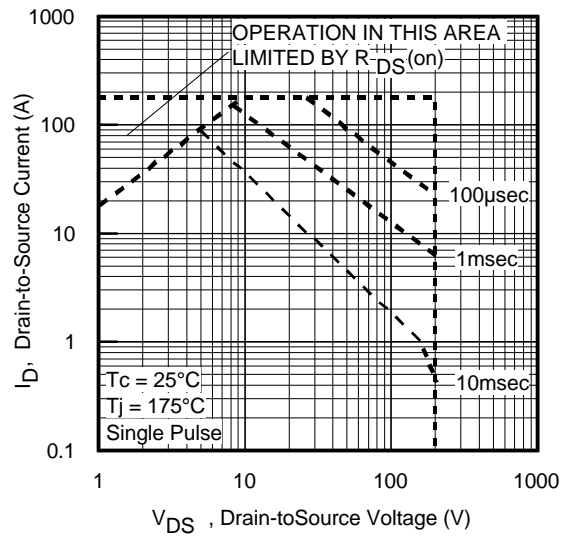
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



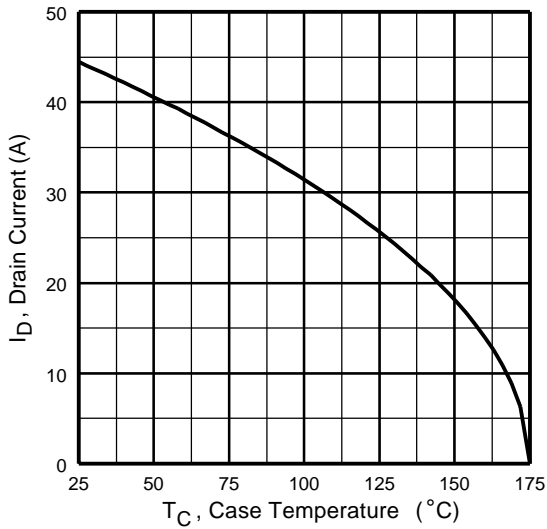
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area



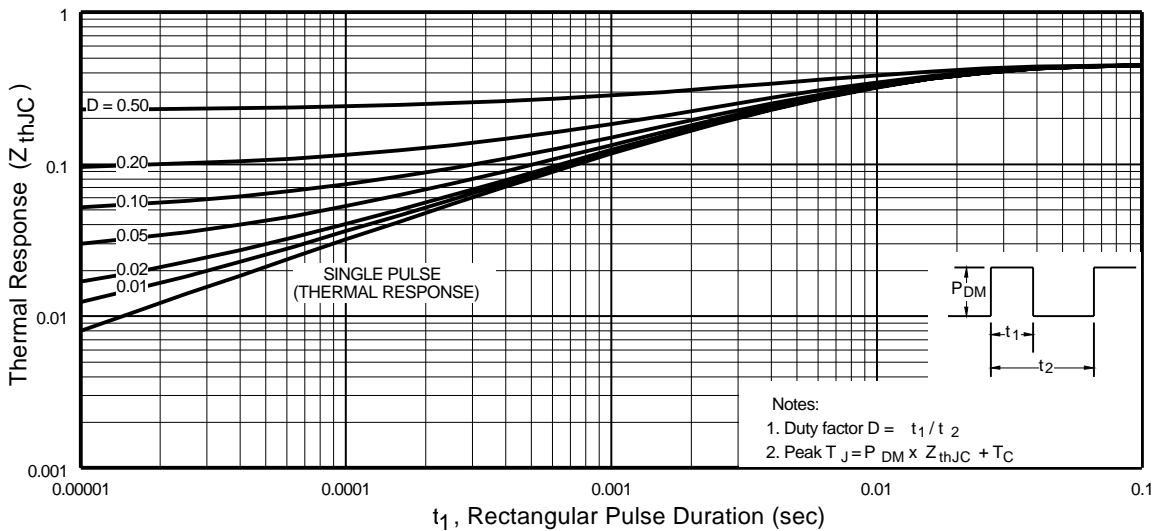
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



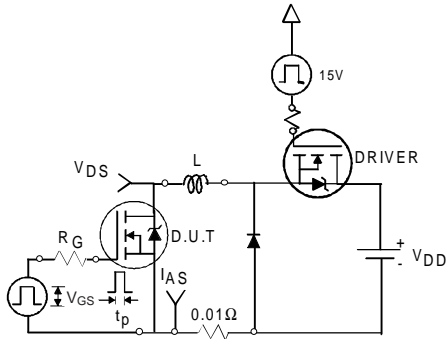
**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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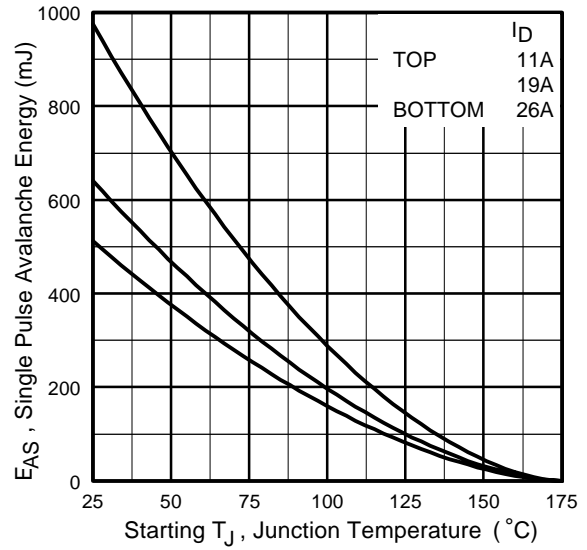
International  
**IR** Rectifier



**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

**Peak Diode Recovery dv/dt Test Circuit**



\*  $V_{GS} = 5V$  for Logic Level Devices

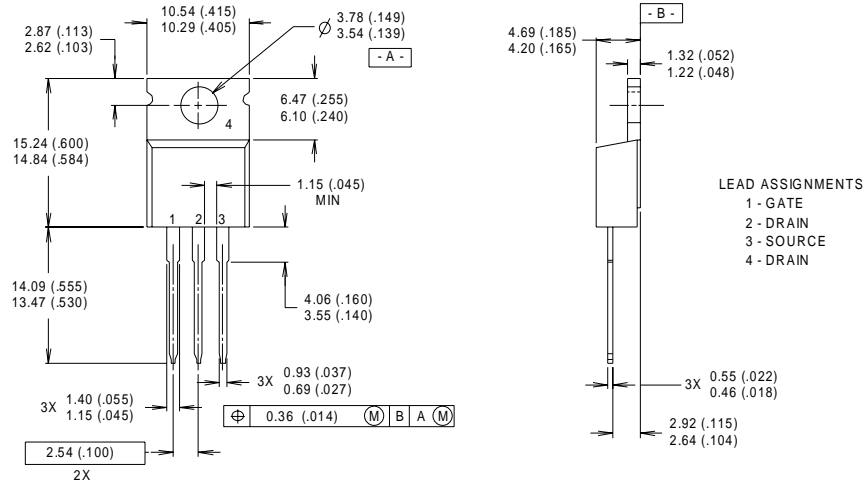
**Fig 14.** For N-Channel HEXFET® Power MOSFETs

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## TO-220AB Package Outline

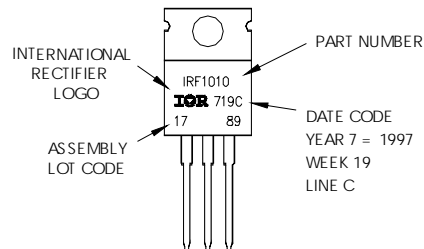
Dimensions are shown in millimeters (inches)



- NOTES:**
- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
  - 2 CONTROLLING DIMENSION : INCH
  - 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
  - 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON VWV 19, 1997  
 IN THE ASSEMBLY LINE "C"



### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 1.45\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 26\text{A}$ ,  $V_{GS} = 10\text{V}$
- ③  $I_{SD} \leq 26\text{A}$ ,  $di/dt \leq 110\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{OSS}$  eff. is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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